# liste des participants/

# list of participants

# I. ÉTATS membres/member STATES

(dans l’ordre alphabétique des noms français des États)

(in the alphabetical order of the names in French)

## ALLEMAGNE/GERMANY

Armin BARTHEL (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Elisabeth ESSEL (Ms.), Senior Patent Examiner, Classification Systems Section, German Patent and Trademark Office (DPMA), Munich

Martina FRITZSCHE-HENKE (Ms.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Justus Sebastian KRUSE (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office, Munich

Steffen MÜNCH (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich,

Alessandra SANI (Ms.), Senior Adviser, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Thomas SCHENK (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Florian SIEBEL (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Michaela Katja STANGL (Ms.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Oliver STEINKELLNER (Mr.), Head, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Veronika TINKL (Ms.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

## ARABIE SAOUDITE/SAUDI ARABIA

Abdulhakim ALSAEED (Mr.), Senior Examiner, IP Operations Patents / Mechanical Engineering Department, Saudi Authority for Intellectual Property (SAIP), Riyadh

Fahad ALNAFJAN (Mr.), Patents Expert, Patents Directorate, Saudi Authority for Intellectual Property (SAIP), Riyadh

Rawabi ALMUHIMED (Ms.), Patent Examination Specialist, Patents Department, Saudi Authority for Intellectual Property (SAIP), Riyadh

Abdulhakim ALSAEED (Mr.), Senior Examiner, IP Operations, Patents/ Mechanical Engineering Department, Saudi Authority for Intellectual Property (SAIP), Riyadh

Abdullah ALGHAMDI (Mr.), Patents Expert, Patents Department, Saudi Authority for Intellectual Property (SAIP), Riyadh

Faisal Saihan S. ALOTAIBI (Mr.), Senior IP Information Analyst, IP Information Center, Saudi Authority for Intellectual Property (SAIP), Riyadh

## AUSTRALIE/AUSTRALIA

Lloyd JAMES (Mr.), Examiner, Patents Examination Group, IP Australia, Canberra

Markus KLAIBER (Mr.), Examiner, Patents Examination Group, IP Australia, Canberra

Deb MCDONNELL (Ms.), Examiner, Patents Examination Group, IP Australia, Melbourne

Alex SIMMONS (Mr.), Patent Examiner, Patents Examination Group, IP Australia, Canberra

Mu-En TIEN (Mr.), Patent Examiner, Patents Examination Group, IP Australia, Canberra

## BRÉSIL/BRAZIL

Darcio GOMES PEREIRA (Mr.), National Institute of Industrial Property (INPI), Ministry of Economy, Campinas, São Paulo, Brazil

Tatielli BARBOSA (Ms.), Patent Examiner, National Institute of Industrial Property (INPI), Ministry of Economy, Rio de Janeiro

Maria Raquel CATALANO DE SOUSA (Ms.), Patent Examiner, National Institute of Industrial Property (INPI), Ministry of Economy, Rio de Janeiro

## CANADA

Nancy BEAUCHEMIN (Ms.), gestionnaire de programme - International CIB/CPC, Office de la propriété intellectuelle du Canada (CIPO) - Direction des brevets, Innovation, Sciences et Développement économique Canada, Gatineau

## CHINE/CHINA

LI Xiao (Ms.), Senior Program Administrator, Patent Documentation Department, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

DONG Qian (Ms.), Deputy Divisional Director, China Patent Technology Development Corporation, China National Intellectual Property Administration (CNIPA), Beijing

LI Bo (Ms.), Divisional QC Manager, China Patent Technology Development Corporation, China National Intellectual Property Administration (CNIPA), Beijing

NAN Nan (Mr.), Examiner, Patent Examination Cooperation Beijing Center, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

TONG Jingyi (Ms.), Examiner, Patent Examination Cooperation Beijing Center, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

DONG Yan (Ms.), Program Administrator, Patent Documentation Department, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

## ESPAGNE/SPAIN

Elena PINA (Sra.), Técnica Superior Examinadora de Patentes, División de física y de patentes eléctricas, Oficina Española de Patentes y Marcas, Ministerio de Industria, Comercio y Turismo (OEPM), Madrid

## ESTONIE/ESTONIA

Tiina LILLEPOOL (Ms.), Principal Examiner, The Estonian Patent Office, Tallinn

## ÉTATS-UNIS D'AMÉRIQUE/UNITED STATES OF AMERICA

William BREWSTER (Mr.), Supervisor Patent Classifying, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Matthew BROOKS (Mr.), Supervisory Patent Classifier - Mechanical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Jill GRAY (Ms.), Patent Classifier - Chemical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Chris JETTON (Mr.), Mechanics Classifier, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Gustavo LOPEZ (Mr.), Patent Classifier - Electrical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Yasmine FULENA (Ms.), IP Advisor, USUN Geneva, Geneva

Marina LAMM (Ms.), IP Attaché, USUN Geneva, Geneva

## FÉDÉRATION DE RUSSIE/RUSSIAN FEDERATION

Vladislav MAMONTOV (Mr.), Head, Multilateral Cooperation Division, International Cooperation Department, Federal Service for Intellectual Property - Rospatent, Moscow

Lada TSIKUNOVA (Ms.), Deputy Head, IPC, Federal Service for Intellectual Property - Rospatent, Moscow

## FINLANDE/FINLAND

Hanna AHO (Ms.), Head of Division, Patents and Trademarks, Mechanical and Civil Engineering, Finnish Patent and Registration Office (PRH), Helsinki

## FRANCE

Magalie MATHON (Mme), examinatrice en charge de mission CIB, Département des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

David DURIEZ (M.), expert en chimie, Département des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

Géraldine VENTORUZZO (Mme), expert en électricité, Département des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

Carole BREMEERSCH (Mme), conseillère propriété intellectuelle, Pole économique, Mission permanente, Genève

## IRLANDE/IRELAND

Fergal BRADY (Mr.), Examiner of Patents, Patent Examination, Intellectual Property Office of Ireland, Department of Enterprise, Trade and Employment, Kilkenny

## ISRAËL/ISRAEL

Orit REGEV (Ms.), Deputy Superintendent of Examiners, Israel Patent Office, Ministry of Justice, Jerusalem

## JAPON/JAPAN

Sumio MIGITA (Mr.), Deputy Director, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Satoshi ABE (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Kotaro FUJISHIMA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Shota HOSOKAWA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Michiru MIURA (Ms.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Kazuhide NAKANO (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Ayano NISHITA (Ms.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Yuto NISHIZUKA (Mr.), Assistant Director, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Yusuke OKATANI (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Toshinori OTSUKA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Tokyo

Takuya YASUI (Mr.), First Secretary, Permanent Mission of Japan, Permanent Mission, Geneva

## MEXIQUE/MEXICO

Kevin Uriel ALENCASTER VILLA (Sr.), IP Expert, Divisional Direction of International Affairs, Mexican Institute of Industrial Property (IMPI), Mexico City

Pedro Christian AYALA ROSALES (Sr.), IP Expert, Divisional Direction of Patents, Mexican Institute of Industrial Property (IMPI), Mexico City

Ayari FERNANDEZ SANTA CRUZ RUIZ (Sra.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

Miguel GONZALEZ AGUILAR (Sr.), IP Expert, Divisional Direction of Patents, Mexican Institute of Industrial Property (IMPI), Mexico City

Diana HEREDIA GARCÍA (Sra.), Divisional Director, Divisional Direction of International Affairs, Mexican Institute of Industrial Property (IMPI), Mexico City

Gustavo JARAMILLO NAVARRETE (Sr.), IP Expert, Divisional Direction of Patents, Mexican Institute of Industrial Property (IMPI), Ciudad de México

Alicia MARMOLEJO FLORES (Sra.), IP Expert, Divisional Direction of Patents, Mexican Institute of Industrial Property (IMPI), Mexico City

Pablo ZENTENO MARQUEZ (Sr.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

Hosanna MORA GONZÁLEZ (Sra.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

## NORVÈGE/NORWAY

Bente AARUM-ULVÅS (Ms.), Senior Examiner, Norwegian Industrial Property Office (NIPO), Oslo

## PAYS-BAS/NETHERLANDS

Robert SCHOUWENAARS (Mr.), Technical Advisor, Netherlands Patent Office, Ministry of Economic Affairs, The Hague

## RÉPUBLIQUE DE CORÉE/REPUBLIC OF KOREA

PARK Sungchul (Mr.), Deputy Director, Patent Legal Administration Division, Daejeon

Wangseok LEE (Mr.), Head of Group, IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

CHA HyunSoo (Mr.), Research Engineer, IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

JUNG Juhee (Ms.), IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

KIM Joohyeok (Mr.), Research Engineer, IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

LEE Jaehoen (Mr.), IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

PARK Hyunchul (Mr.), IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

YOON Inseok (Mr.), IPC Revision Group, Patent Information Promotion Center (PIPC), Daejeon

LEE Jinyong (Mr.), IP Attache, Economy, Permanent Mission, Geneva

## RÉPUBLIQUE TCHÈQUE/CZECH REPUBLIC

Jarmila AVRATOVA (Ms.), Engineer, Patent Information, Industrial Property Office of the Czech Republic, Prague

## ROUMANIE/ROMANIA

Florica ENEA (Ms.), Examiner and Head of Department, Electrical Department, State Office for Inventions and Trademarks (OSIM), Bucharest

Ana PREJBEANU (Ms.), Examiner, Formal Examination, State Office for Inventions and Trademarks (OSIM), Bucharest

## ROYAUME-UNI/UNITED KINGDOM

Jeremy COWEN (Mr.), Senior Patent Examiner - Classification, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Patrick PURCELL (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

William (Bill) RIGGS (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Huw THOMAS (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Rhys WILLIAMS (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Jan WALTER (Mr.), Senior IP Adviser, Permanent Mission, Geneva

## SUÈDE/SWEDEN

Anders BRUUN (Mr.), Patent Expert, Swedish Intellectual Property Office (PRV), Stockholm

Tomas LUND (Mr.), Senior Patent Examiner, Swedish Intellectual Property Office (PRV), Stockholm

## SUISSE/SWITZERLAND

Pascal WEIBEL (M.), chef Examen, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

Philippe TATASCIORE (M.), expert en brevet, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

Michael STALDER (M.), expert en brevet, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

Charlotte BOULAY (Mme), Legal Advisor, Division of Legal and International Affairs, Swiss Federal Institute of Intellectual Property, Bern

## UKRAINE

Bohdan PADUCHAK (Mr.), Deputy Director, Department for Intellectual Property, Ministry of Economy of Ukraine, Kyiv

# II. ÉTATS OBSERVATEURS/OBSERVER STATES

## HONGRIE/HUNGARY

Ildikó DIÓSPATONYI (Ms.), Patent Examiner, Pharmaceuticals and Agriculture Section, Hungarian Intellectual Property Office (HIPO), Budapest

Zsuzsanna TÖRŐCSIK (Ms.), Patent Examiner, Chemistry and Biotechnology Section, Hungarian Intellectual Property Office (HIPO), Budapest

## INDE/INDIA

A. Seetha Raman (Mr.), Examiner of Patents and Designs, Department for Promotion of Industry and Internal Trade (DPIIT), Ministry of Commerce and Industry, Chennai

Saurabh DWIVEDI (Mr.), Examiner of Patents and Designs, Department for Promotion of Industry and Internal Trade (DPIIT), Ministry of Commerce and Industry, Kolkata

Vishakha GUPTA (Ms.), Examiner of Patents and Designs, Department for Promotion of Industry and Internal Trade (DPIIT), Ministry of Commerce and Industry, New Delhi

## SINGAPOUR/SINGAPORE

Ning DU (Ms.), Patent Examiner, Patent Search, Examination and Analytics, Intellectual Property Office of Singapore (IPOS), Singapore

Lei HONG (Mr.), Senior Patent Examiner, Patent Search, Examination and Analytics, Intellectual Property Office of Singapore (IPOS), Singapore

Cheow Hin SIM (Ms.), Patent Examiner, Patent Search, Examination and Analytics, Intellectual Property Office of Singapore (IPOS), Singapore

Happy TAN (Mr.), Senior Patent Examiner, Patent Search, Examination and Analytics, Intellectual Property Office of Singapore (IPOS), Singapore

# III. ORGANISATIONS INTERNATIONALES INTERGOUVERNEMENTALES/ INTERNATIONAL INTERGOVERNMENTAL ORGANIZATIONS

## ORGANISATION EURASIENNE DES BREVETS (OEAB)/EURASIAN PATENT ORGANIZATION (EAPO)

Dmitrii GUDILIN (Mr.), Principal Examiner, Mechanics, Physics and Electrical Engineering Division, Examination Department, Moscow

Elena LUBYAKO (Ms.), Principal Examiner, Chemistry and Medicine Division, Examination Department, Moscow

Valery MALAY (Mr.), Principal Examiner, Mechanics, Physics and Electrical Engineering Division, Examination Department, Moscow

## ORGANISATION EUROPÉENNE DES BREVETS (OEB)/EUROPEAN PATENT ORGANISATION (EPO)

Roberto IASEVOLI (Mr.), Head, Classification Board, Rijswjk

Maarten ALINK (Mr.), Classification Board, Munich

Jérôme CARRÉ (Mr.), Classification Board, Munich

Massimo CRESCENTI (Mr.), Classification Board, Rijswjk

Agnès GAMEZ MERLE (Ms.), Classification Board, Rijswjk

Nathalie GEISLER (Ms.), Classification Board, Rijswjk

Silvia GENNARI (Ms.), Classification Board, Munich

Ciro PERNICE (Mr.), Classification Board, Rijswjk

Mark PLEHIERS (Mr.), Classification Board, Rijswjk

John RENGGLI (Mr.), Classification Board, Munich

Peter SWARÉN (Mr.), Classification Board, Rijswijk

Erik TORLE (Mr.), Classification Board, Munich

Daniela VANATA (Ms.), Classification Board, Munich

Rossana VINCI (Ms.), Classification Board, Rijswijk

Norbert WIENOLD (Mr.), Classification Board, Munich

# IV. BUREAU/OFFICERS

président/Chair: Oliver STEINKELLNER (M./Mr.) (ALLEMAGNE/GERMANY)

vice-président/ Pascal WEIBEL (M./Mr.) (SUISSE/SWITZERLAND)  
Vice Chair

secrétaire/Secretary: XU Ning (Mme/Ms.) (OMPI/WIPO)

# V. BUREAU INTERNATIONAL DE L’ORGANISATION MONDIALE DE LA PROPRIÉTÉ INTELLECTUELLE (OMPI)/ INTERNATIONAL BUREAU OF THE WORLD INTELLECTUAL PROPERTY ORGANIZATION (WIPO)

Ken-Ichiro NATSUME (M./Mr.), sous-directeur général du Secteur de de l’infrastructure et des plateformes/Assistant Director General, Infrastructure and Platforms Sector

Kunihiko FUSHIMI (M./Mr.), directeur de la Division des classifications internationales et des normes, Secteur de de l’infrastructure et des plateformes/Director, International Classifications and Standards Division, Infrastructure and Platforms Sector

XU Ning (Mme/Ms.), chef de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l’infrastructure et des plateformes/Head, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

Rastislav MARČOK (M./Mr.), administrateur principal de la classification des brevets de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l’infrastructure et des plateformes/Senior Patent Classification Officer, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

Olivier COLLIOUD (M./Mr.), Administrateur de projets la de la Section des systèmes informatiques, Division des classifications internationales et des normes, Secteur de de l’infrastructure et des plateformes /Project Officer, IT Systems Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

Isabelle MALANGA SALAZAR (Mme/Ms.), assistante à l’information de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l’infrastructure et des plateformes/Information Assistant, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

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